



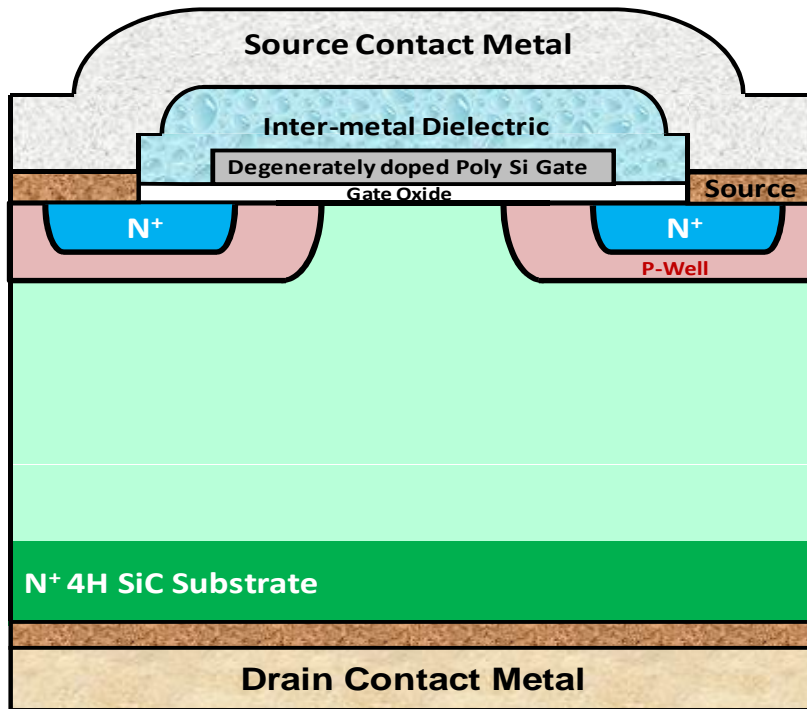
Medium Voltage SiC R&D update

Jeffrey B. Casady, Ty McNutt, Dave Girder & John Palmour

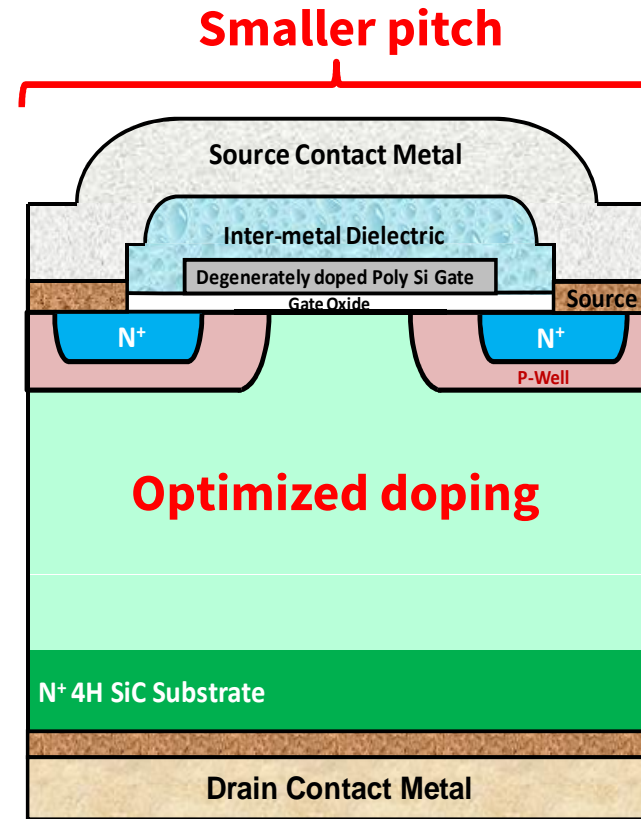
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April 2016

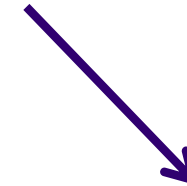
NEXT GENERATION SiC MOSFETS – OVER 5 YEARS IN THE MARKET



Gen 2 DMOS



Gen 3 DMOS

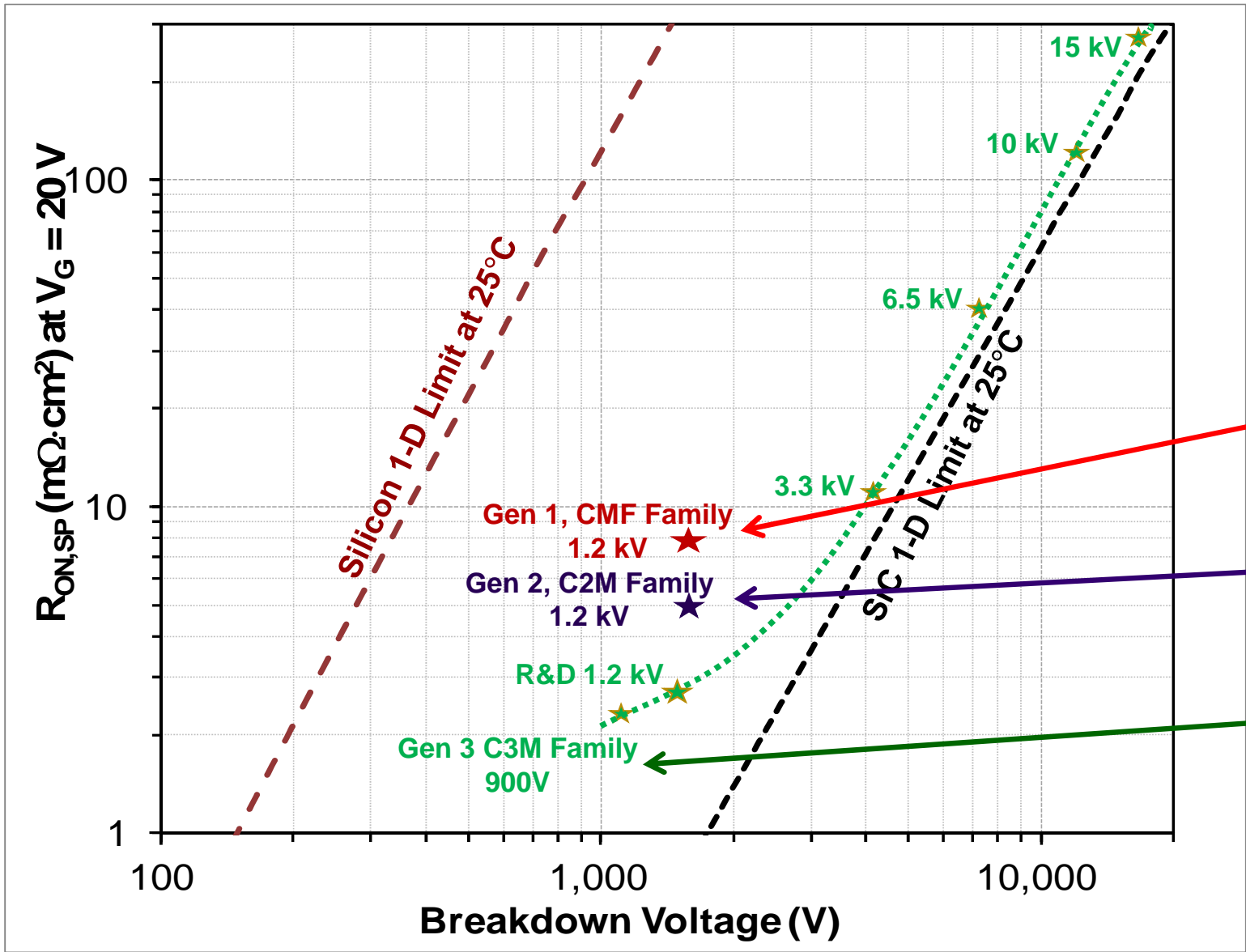


Commercially released in **2013** as “C2M” product family at 1.2-1.7kV

Commercially released in **2015** as “C3M” product family at 900V

Same high reliability DMOS Structure, but optimized to dramatically reduce die size

WOLFSPEED NEXT-GEN SiC DMOS LOWERS SPECIFIC R_{DSON} DRAMATICALLY



**2011 release
(1200V)**

**2013 release
(1200V & 1700V)**

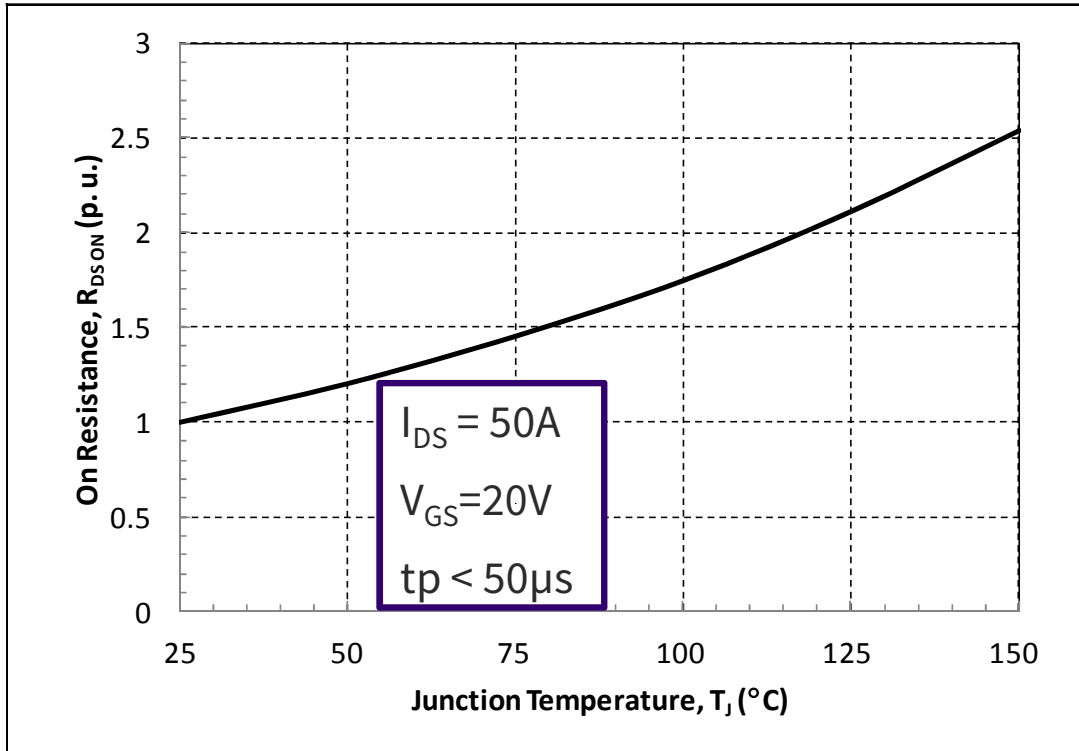
**2015 release
(900V)**

Reference: J. Palmour, et al (ISPSD 2014)

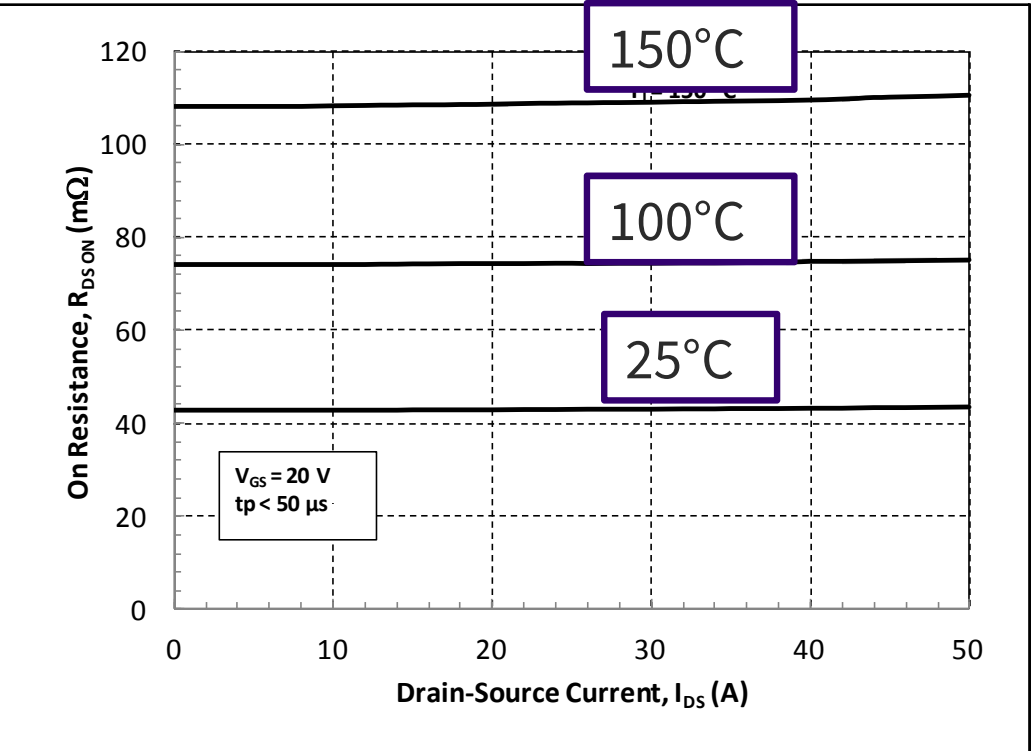
New 900V SiC MOSFET released is $2.3m\Omega \cdot cm^2$



3.3kV, 45mΩ SiC MOSFET CHIP $R_{DS(ON)}$ vs T and I_{DS}



Normalized On-Resistance vs. Temperature

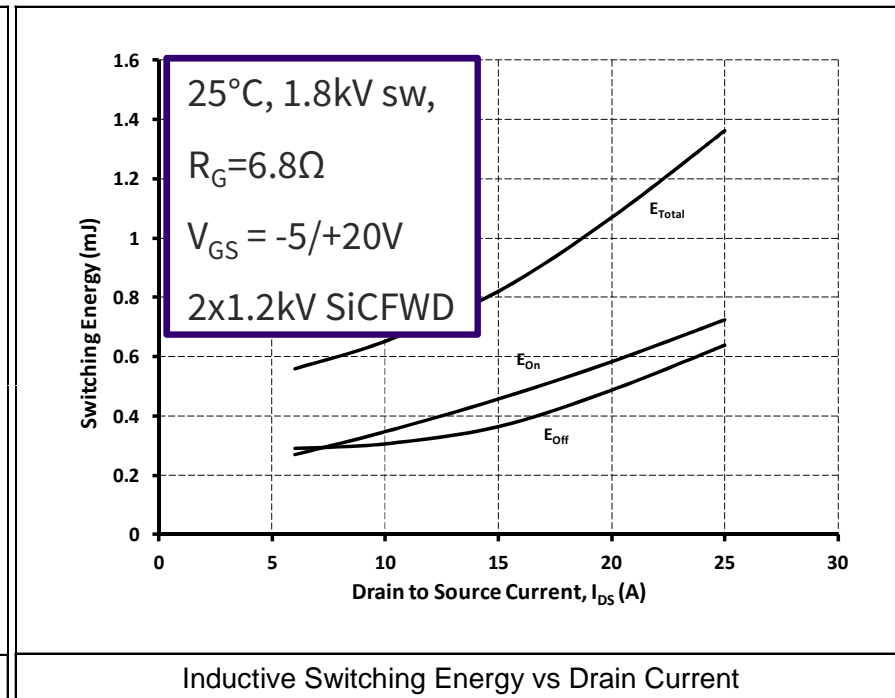
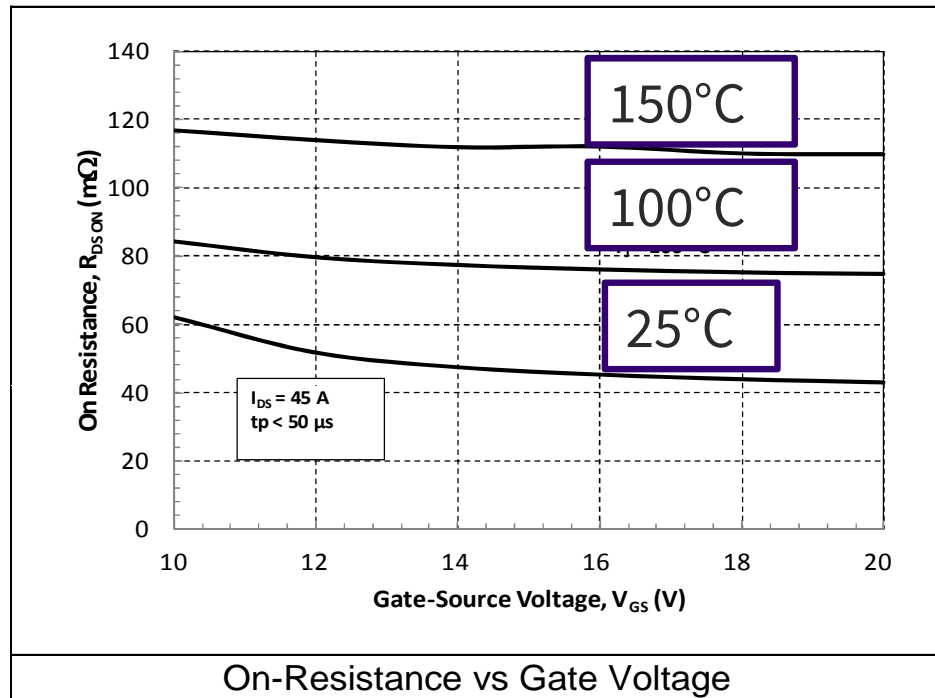


On-Resistance vs. Drain Current

- 2.5X increase in $R_{DS(ON)}$ from 25°C to 150°C
- Positive temperature coefficient
- Devices can be readily paralleled

Reference: J. Casady, et al (ECCE 2015)

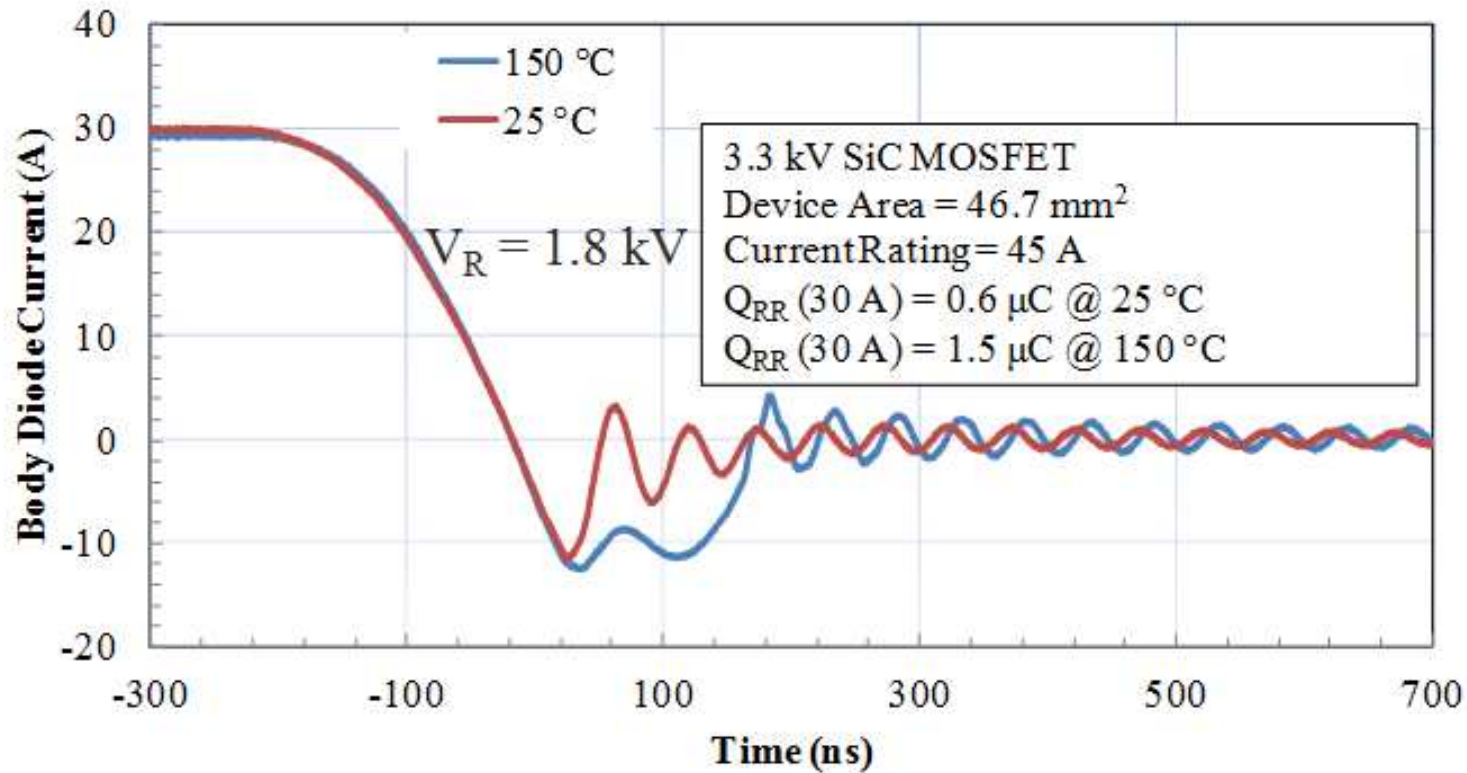
3.3kV, 45mΩ SiC MOSFET CHIP R_{DSON} vs V_{GS}



- At temperature, little change in R_{DSON} above $V_{GS} = +14$ V
- At 1.8kV, 20A (1/2 rated current), $E_T = 1.1$ mJ (858 uH load)

Reference: J. Casady, et al (ECCE 2015)

3.3kV, 45mΩ SiC MOSFET CHIP BODY DIODE



- SiC body diode can eliminate external anti-parallel SiC diode
- Elimination of external anti-parallel diode saves cost and space
- Third quadrant operation of MOSFET possible for additional savings

Reference: J. Casady, et al (ECCE 2015)

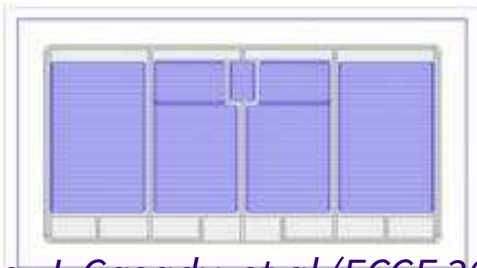
3.3kV/180A SiC HALF-BRIDGE EVALUATION MODULE

For Quick Evaluation

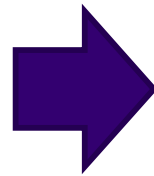
- Each switch position contains:
 - Four (4) 3.3kV SiC MOSFETs (~45A each) and
 - Four (4) 3.3kV anti-parallel SiC diodes (~45A each)
- 62mm module / No snubber used

3.3kV SiC MOSFET chip

V_{DS}	3300 V
$I_D (T_C=90^\circ C)$	45 A
$R_{DS}(25^\circ C)$	45 mΩ



Reference: J. Casady, et al (ECCE 2015)

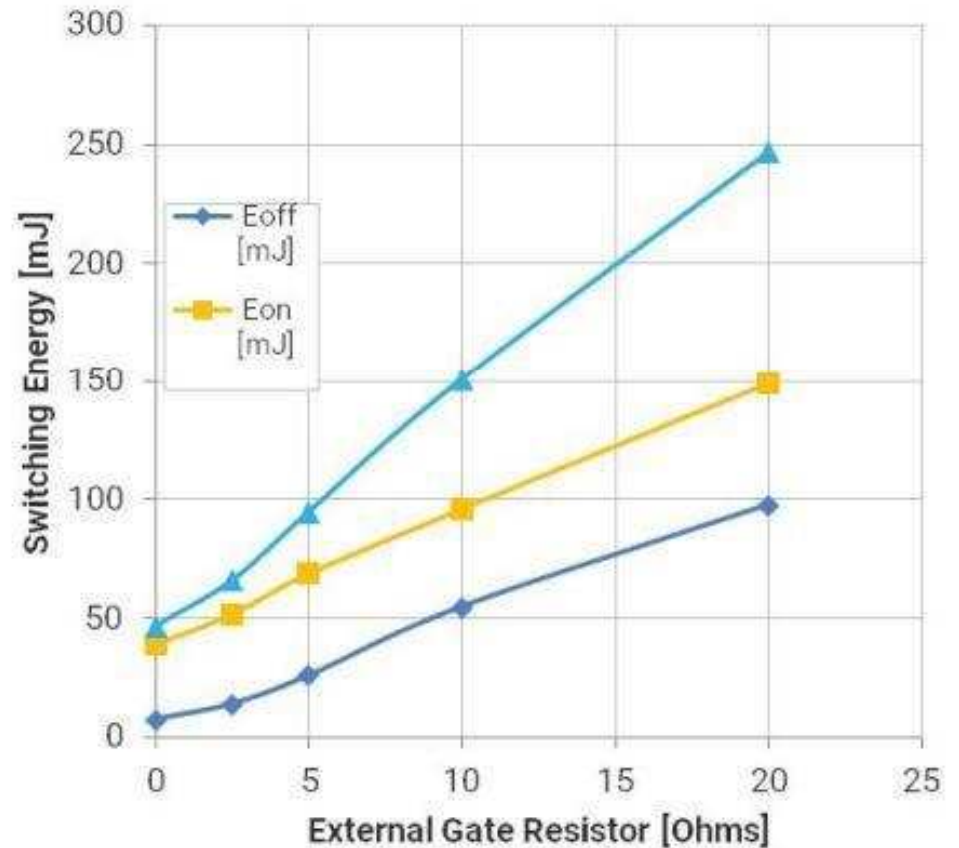
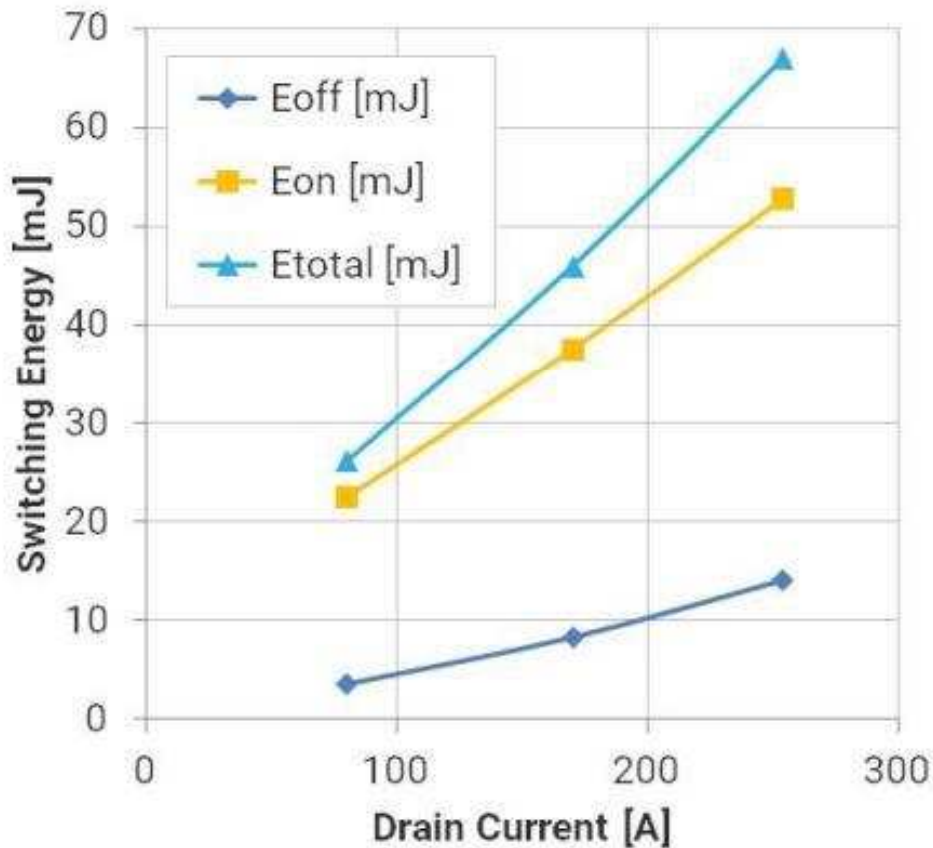


3.3kV SWITCHING LOSS PERFORMANCE @ 25°C

Double Pulse Test

Vlink = 2.2 kV, Rg_ext = 2.5 Ω

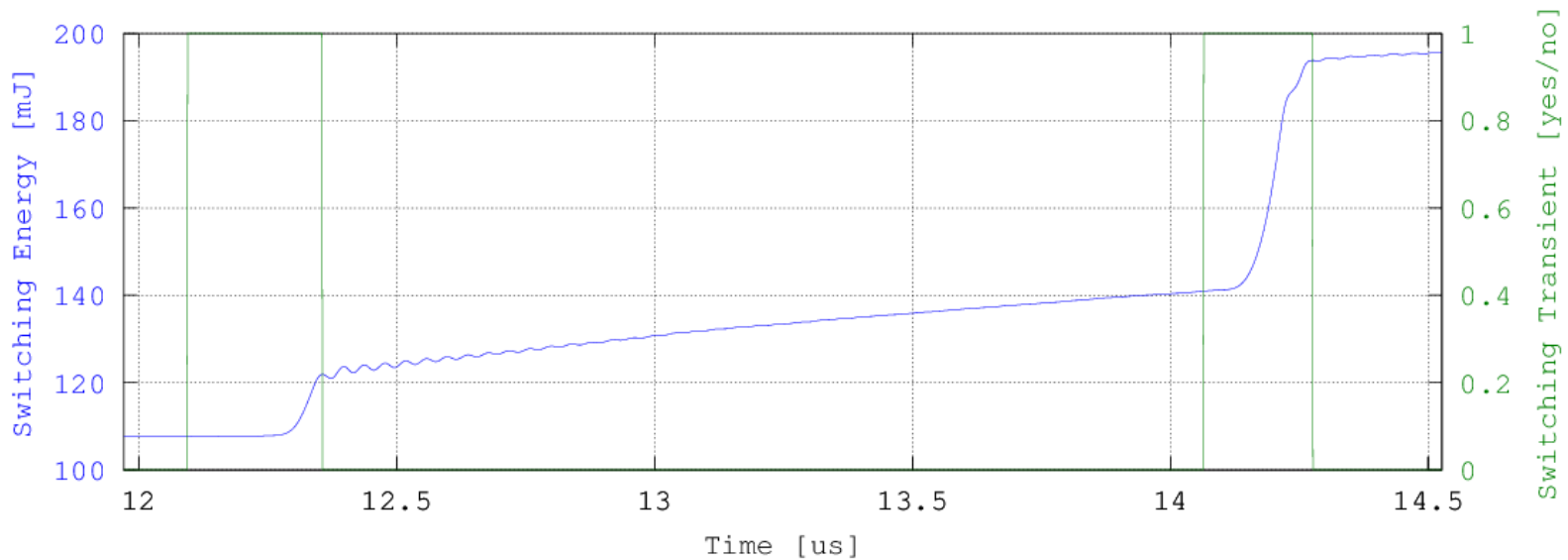
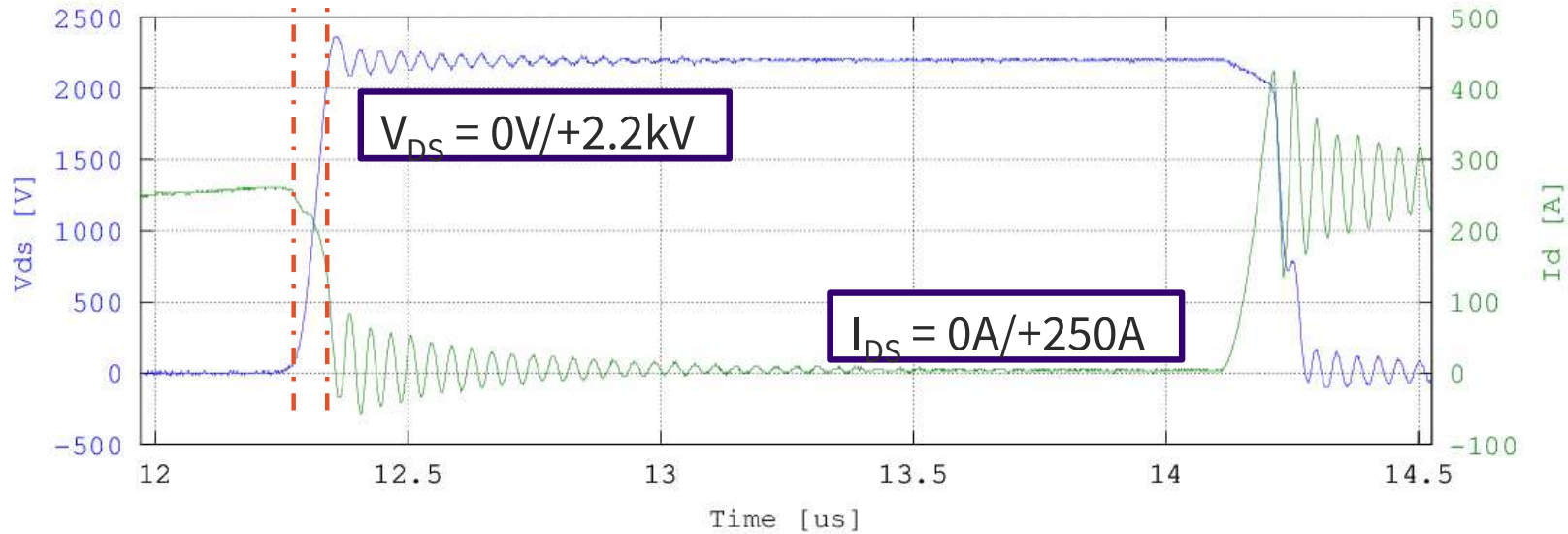
Vlink = 2.2 kV, Ids = 250 A



- At 2.2kV, 180A switching event, **45mJ** total switching energy
- **3.3kV SiC MOSFETs switching losses are 10-15x lower than 3.3kV Si IGBTs**

Reference: J. Casady, et al (ECCE 2015)

250A/2.2kV SWITCHING EVENT WITH $R_{G_EXT} = 2.5 \Omega$

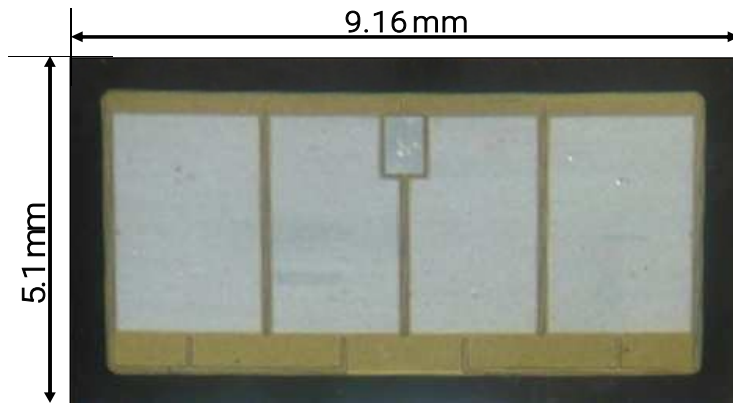


Reference: J. Casady, et al (ECCE 2015) Switching speed <150ns; minimal overvoltage (no snubber)

Improved Gen three 3.3kV, 40mΩ
SiC MOSFET chip

IMPROVED GEN THREE 3.3kV/40mΩ SiC MOSFET

- 8.5 % Reduction in Die Size
- 13.6% Improvement in $R_{DS,ON}$



- Preliminary 3.3kV SiC MOSFET Design
- $R_{DS,ON} = 46.9 \text{ m}\Omega$
- Die Area = 46.7 mm^2

A photograph of a rectangular silicon carbide (SiC) MOSFET die, similar to the one on the left but smaller. Dimension lines indicate a width of 8.86 mm and a height of 4.82 mm. The die is enclosed in a purple-bordered box.

- **Improved** 3.3kV SiC MOSFET Design
- $R_{DS,ON} = 40.5 \text{ m}\Omega$
- Die Area = **42.7** mm^2

SiC XHP™ STYLE MODULE - INDUSTRY STANDARD HOUSING

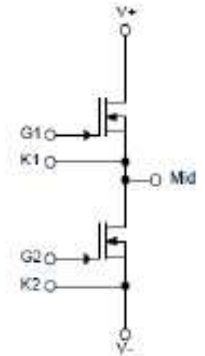
- Engineering Sample sales
- Up to 12 MOSFETs/ switch available
- Ultra-Fast Switching, Low Inductance (<20 nH V+ to V-)
- Companion gate driver
 - Desaturation protection, temperature sensing, programmable UVLO with hysteresis, galvanic signal isolation, & on-board isolated power supplies.

3.3 kV SiC HALF-BRIDGE POWER MODULE N-Channel MOSFET

3.3 kV / 5.7 mΩ

FEATURES

- > High Voltage: $V_{DS} = 3.3 \text{ kV}$, $T_{J(max)} = 175 \text{ °C}$
- > AS9100:Rev. C-Certified Manufacturing, Traceable Throughout Value Chain
- > Ultra-Fast Switching, Low Inductance
- > Enables High System Efficiency
- > "XHP" Style Half-Bridge Power Module



APPLICATIONS

- > Solid-State Transformers
- > Medium Voltage Drives
- > Solid-State Circuit Breakers
- > Smart Grid / Grid-Tie Distributed Generation
- > Energy Storage Systems

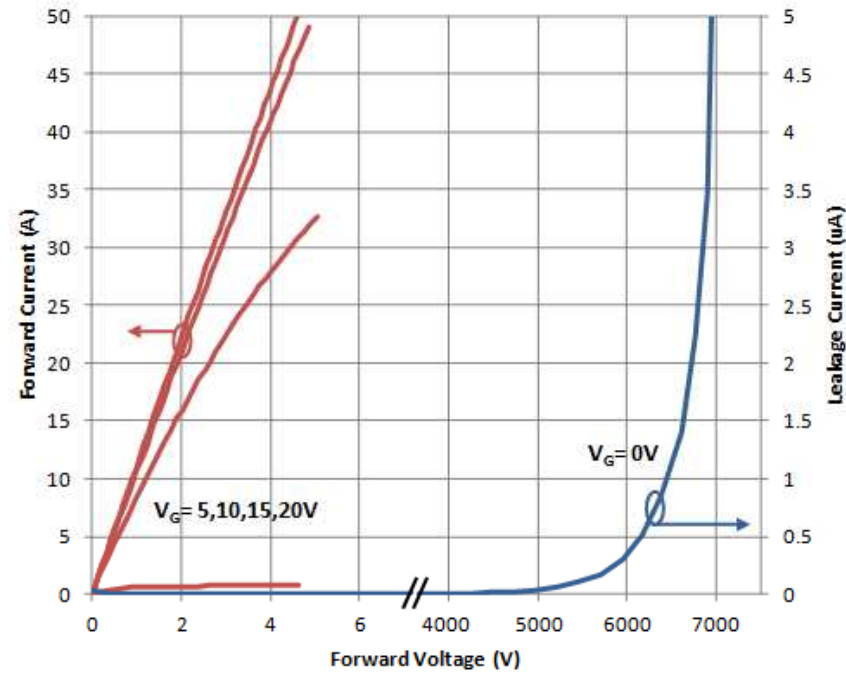
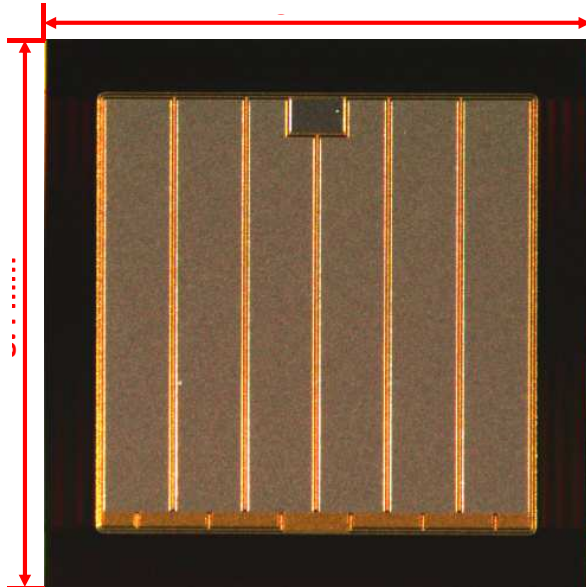
Power Module Absolute Maximum Ratings

Symbol	Parameter	Condition(s)	Value	Units
V_{DSS}	Drain-Source Voltage		3300	V
V_{GSS}	Gate-Source Voltage ¹		-8/+19	
I_D	Continuous Drain Current	$T_C = 25 \text{ °C}$, $T_J = 175 \text{ °C}$		A
		$T_C = 125 \text{ °C}$, $T_J = 175 \text{ °C}$		
P_D	Maximum Power Dissipated	$T_C = 25 \text{ °C}$, $T_J = 175 \text{ °C}$	2586	W
$T_{J(max)}$	Maximum Junction Temperature		175	°C
T_{stg}	Storage Temperature Range		-55 to 175	

Gen three 6.5kV, 100m Ω
SiC MOSFET chip

6.5kV, 100mΩ SiC MOSFET

6.5 kV 30 A MOSFET die photo



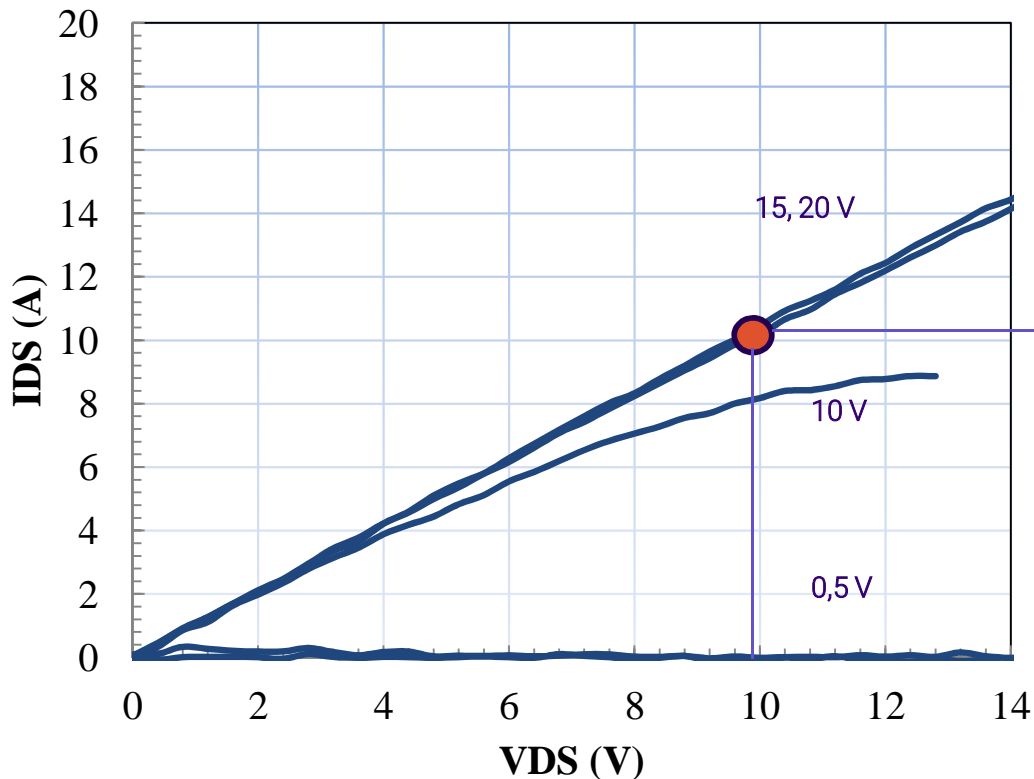
- Nominally a 30A SiC MOSFET
- $R_{DS(on)max}$ at room temp $\sim 100m\Omega$
- $R_{DS(on)max}$ at $90^\circ C \sim 171m\Omega$
 - all parameters subject to change without notice

Improved Gen three 10kV, 350mΩ
SiC MOSFET chip

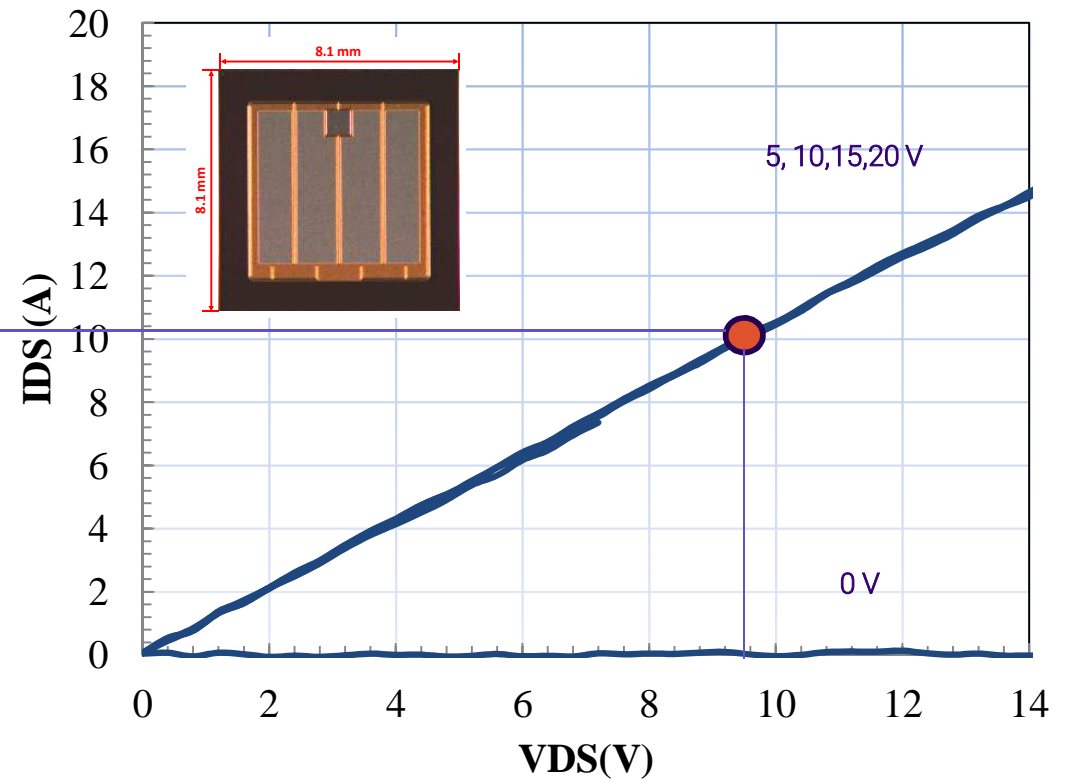
Measured I-V Characteristics at 150°C of Enhanced Short Circuit Capability and Baseline Gen3 10 kV/350 mOhm SiC MOSFETs

- Very Small Difference in On-Resistance ($R_{DS,on}$) at 150 °C
- Enhanced Short Circuit 10 kV SiC MOSFET has Higher Threshold Voltage

**Enhanced Short Circuit Gen3
10kV/350mOhm SiC MOSFET**

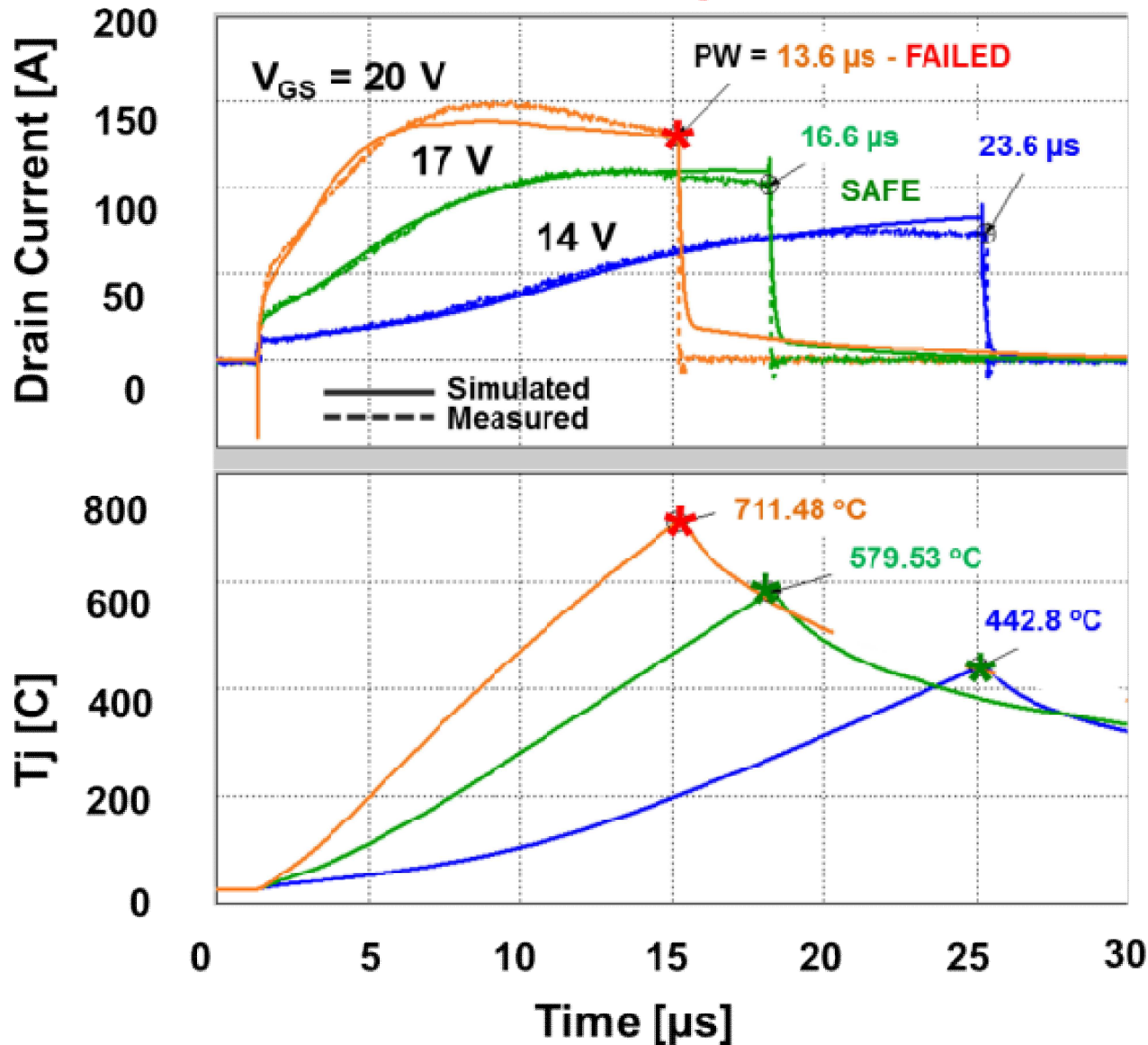


**Baseline Gen3 10kV/350mOhm
SiC MOSFET**



Short Circuit Simulation/Test of Gen 3 10 kV/350 mOhm SiC MOSFETs With Enhanced Short Circuit Capability

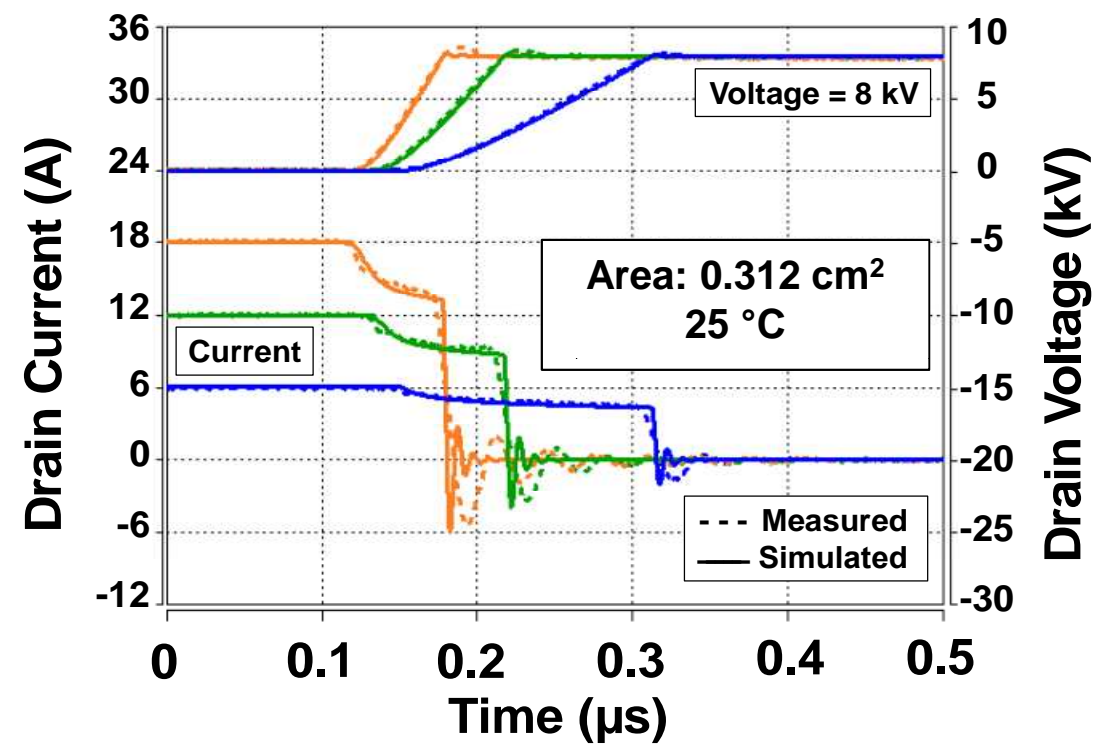
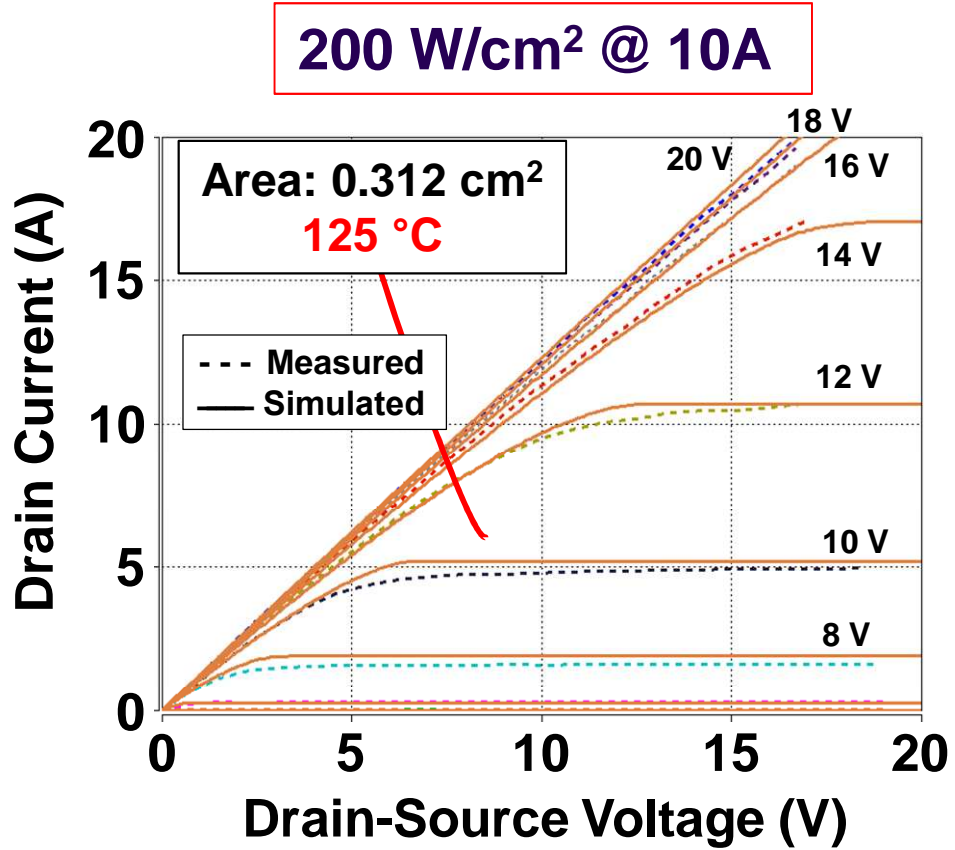
Short Circuit Voltage = 5000 V



- Demonstrated Gen3 10 kV/350 mOhm SiC MOSFETs Capable of Sustaining Short Circuit Current For > 13 μsec at 5000V
- Measurement and Simulation Courtesy of Al Hefner at NIST



Conduction/Switching Measurements and Model of Enhanced Short Circuit Capability Gen3 10 kV/350 mOhm SiC MOSFETs



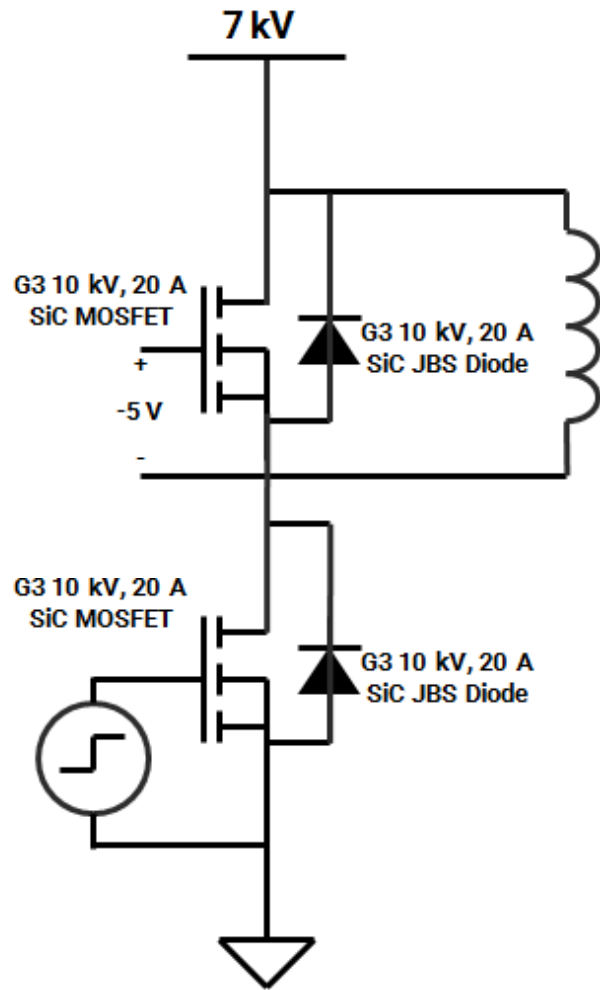
- Measurement and Model
Courtesy of Al Hefner at NIST



10kV Switching Measurements

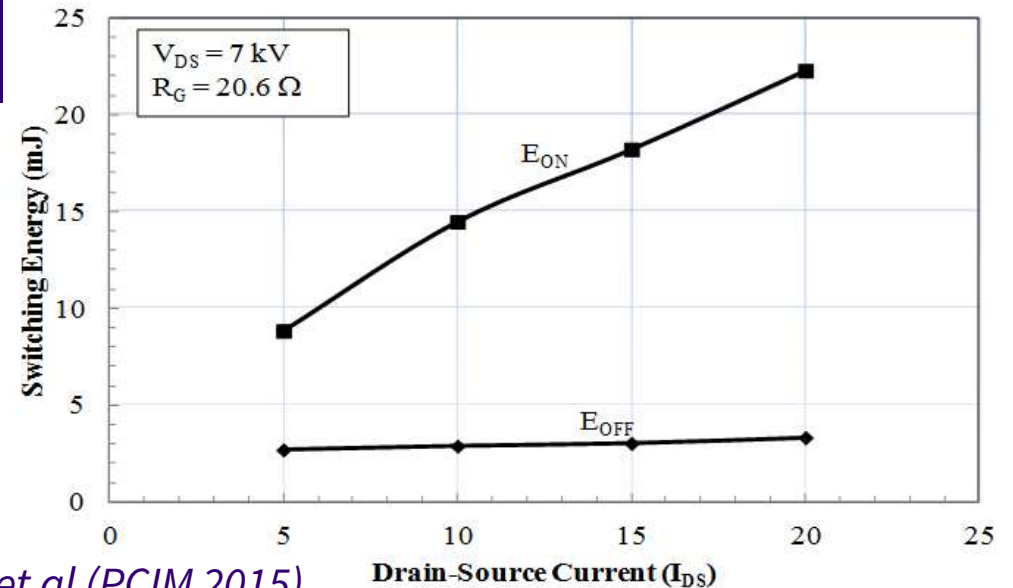
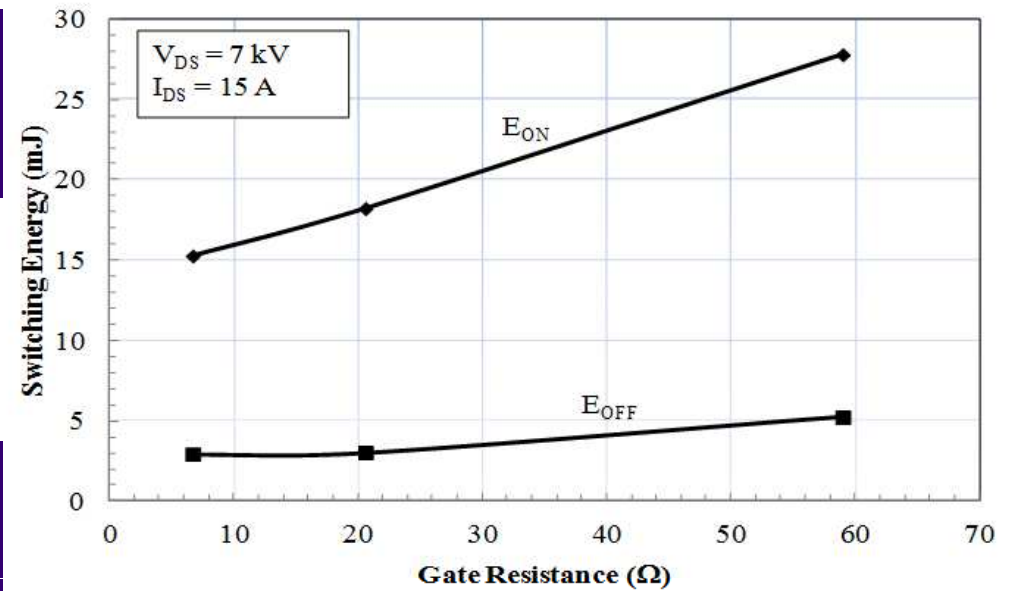
- A. ½ Bridge Configured Measured Switching Energies and Waveforms**
- B. Boost Configured Switching Energies**

½ BRIDGE CONFIGURED MEASURED SWITCHING ENERGIES AND WAVEFORMS



**E_{TS} measured
10-33mJ**

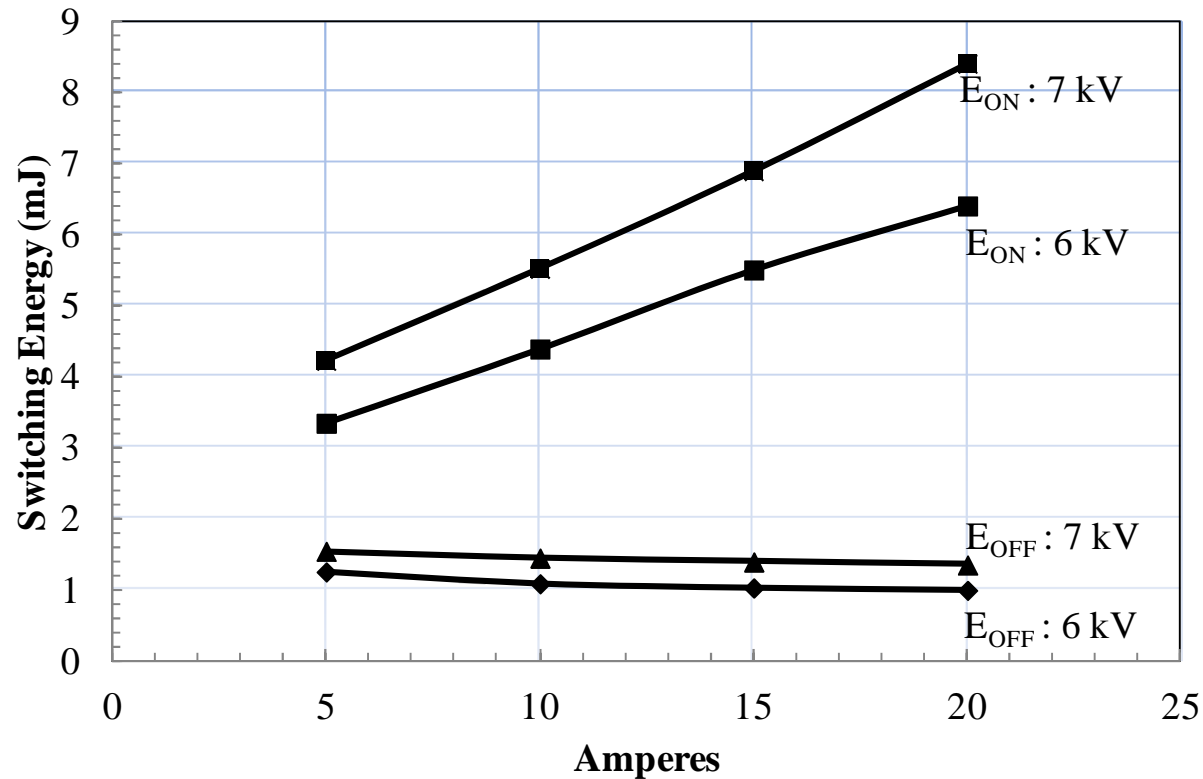
**$E_{TS} = 21\text{mJ}$
at 7kV, 15A,
 $20.6\Omega R_G$**



½ bridge configuration used for switching measurements of a 10kV, 345mΩ SiC MOSFET in both the high position and low positions.

Reference: J. Casady, et al (PCIM 2015)

Boost Configured Switching Energies



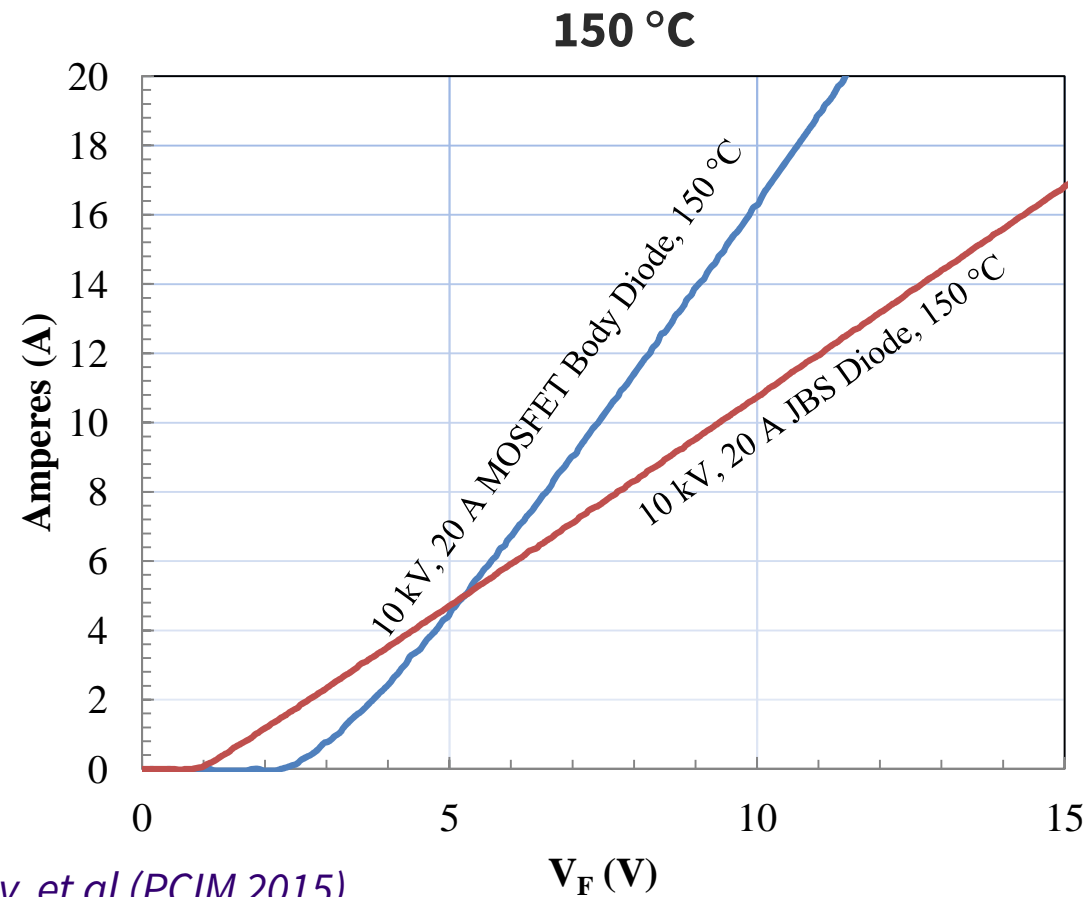
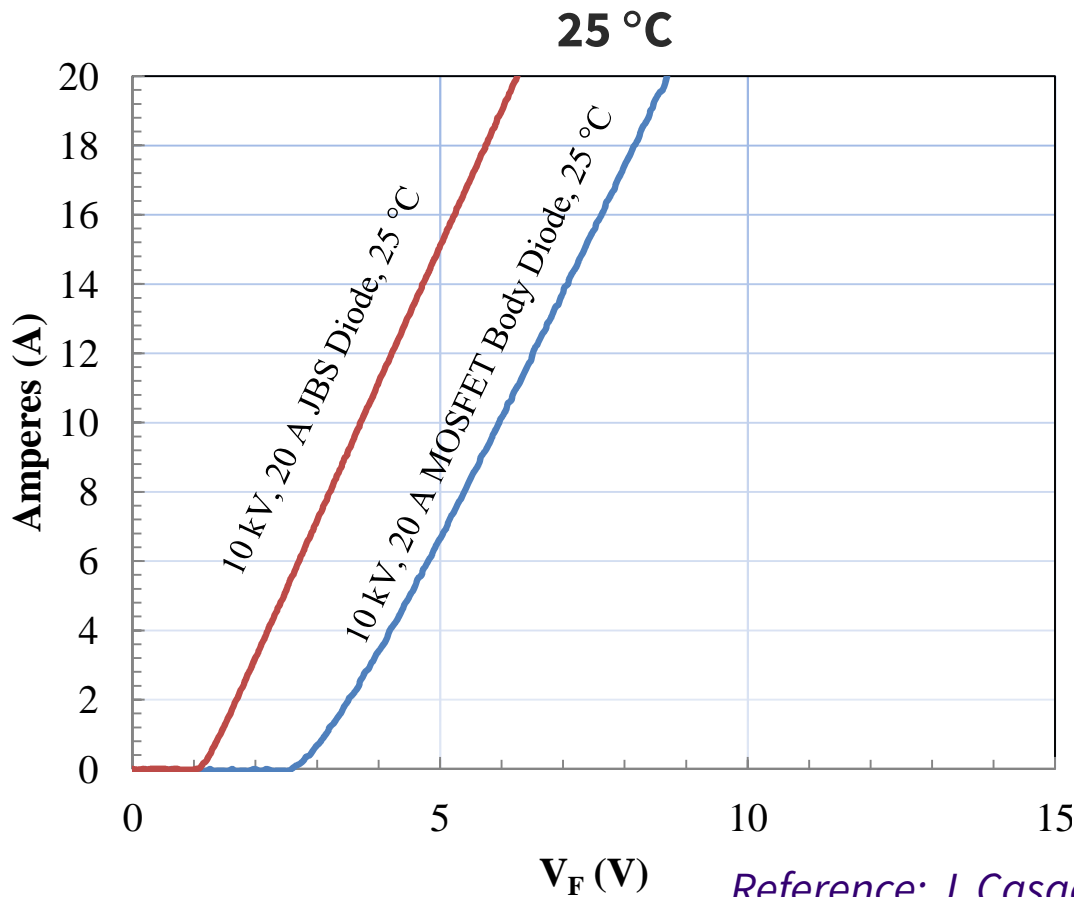
Device	BV	E _{SW, TOTAL}
SiC Gen 3 10kV SiC MOSFET	10 kV	6.5 mJ @ 6kV, 15A
Silicon 6.5kV IGBT ABB 5SMX	6.5 kV	265 mJ @ 3.6kV, 25A

- **New R&D 10kV SiC MOSFETs > 40X lower switching losses than 6.5 kV Si IGBT in boost configuration**
 - Peak switching voltage set by overshoot and cosmic ray FIT - potentially much less de-rating in SiC vs Si

Reference: J. Casady, et al (PCIM 2015)

10 kV BODY DIODE STATIC CHARACTERISTICS

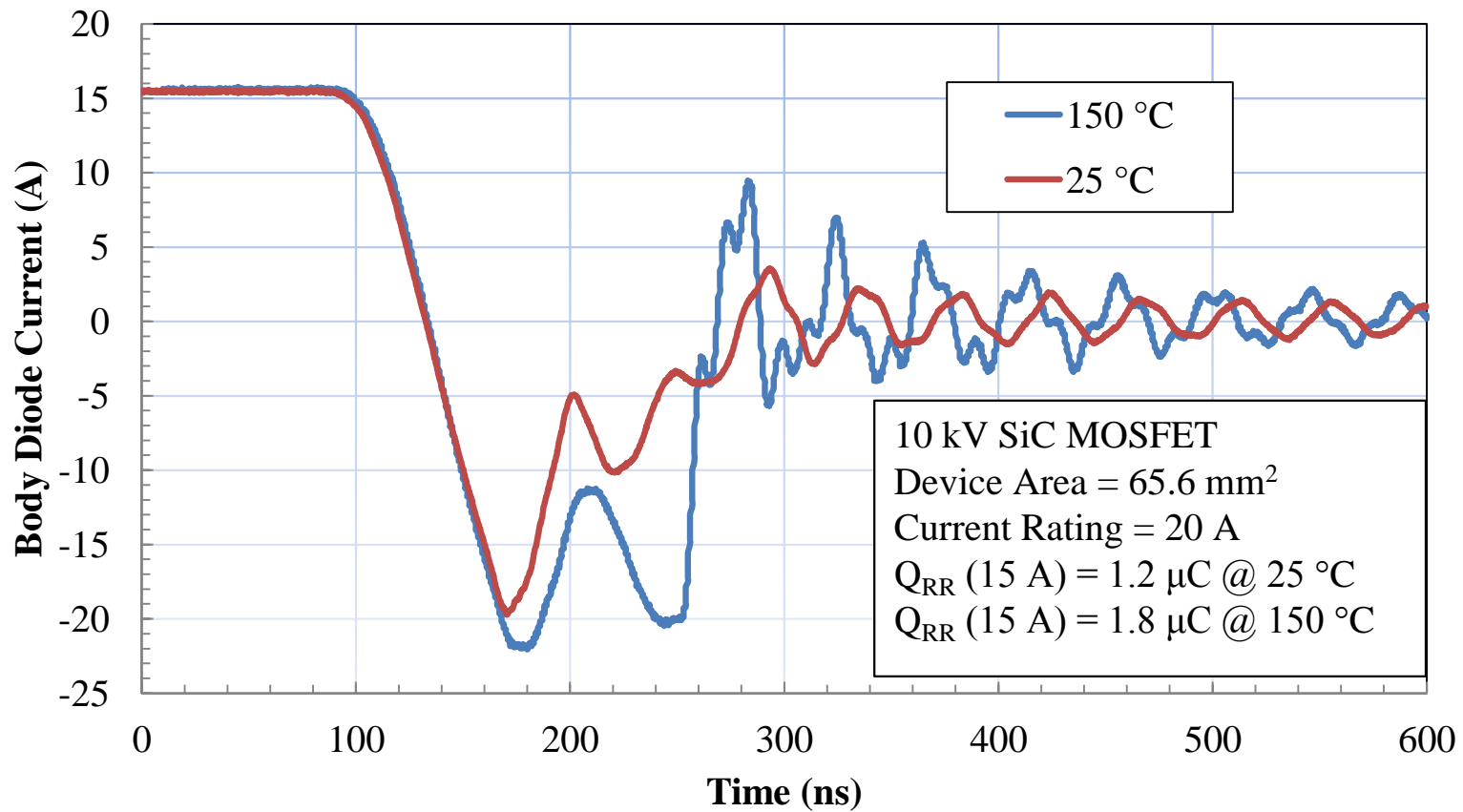
- 10 kV body diode is bipolar – lower resistance than a 10 kV JBS diode at high temperatures
- Reverse conducting antiparallel JBS diode can be eliminated



Reference: J. Casady, et al (PCIM 2015)

10 kV BODY DIODE REVERSE RECOVERY

- 10 kV body diodes show low reverse recovery



Reference: J. Casady, et al (PCIM 2015)

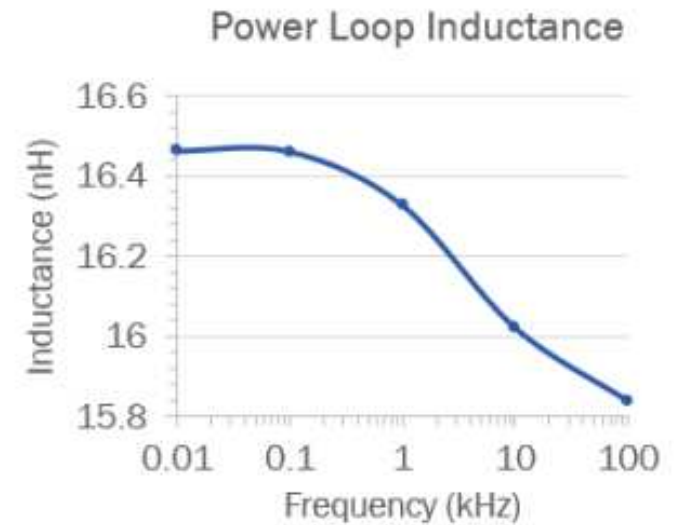
10kV SiC MOSFET XHV-6 POWER MODULE



Funded by ONR
PM: Lynn Petersen

Key Features

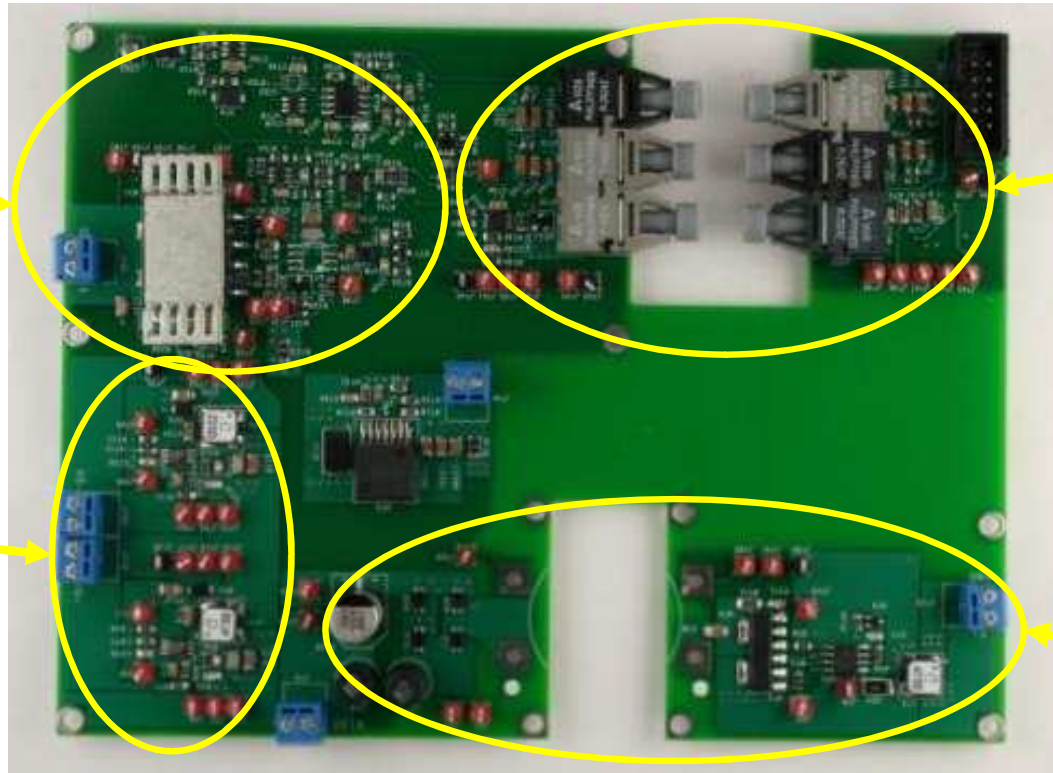
- 10 kV / 240 A, half-bridge power module
- 18 10 kV / 350 mΩ MOSFETs per position
- Low inductance power (~ 16 nH) and gate (~ 10 nH) loops
- Low Rjc (0.026 °C/W per half-bridge switch position)
- Can be configured as a 3-phase module
- Reworkable submodules
- Meets UL 840 and IEC 60664-1 creepage/clearance for a 15 kV module
- Mounts to standard 3x EconoDUAL footprint coldplate



PROTOTYPE GATE DRIVER WITH TARGET $>100 \text{ kV}/\mu\text{s}$ CAPABILITY

Gate Driver output with custom totem pole. Max peak current $>70 \text{ A}$

Non-Isolated DC/DC regulation
Unregulated 10-30V to +20/-5V, or +15/-4V



Fiber-optic control signals, non-isolated side would be on a separate board in final implementation

HV unregulated Isolated ($>10\text{kV}$) Power Supply 20-30V input to 15-30V output

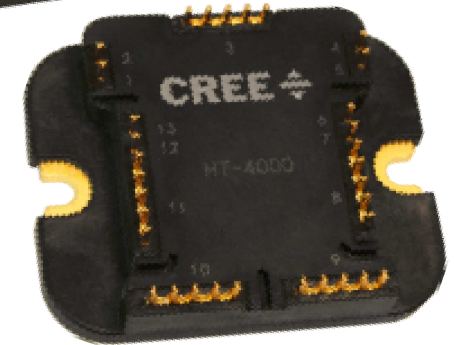
SUMMARY

- **SiC MOSFETs released over 5 years ago**
- **Gen 3 SiC MOSFETs released beginning in 2015 at 900V;**
- **Gen 3 SiC MOSFETs engineering samples at 1.7kV, 3.3kV, 6.5kV and 10kV**
- **Modules available**
 - **Companion gate drivers/power supplies for all modules available**
 - **1.7kV modules using Econodual™ based design**
 - **3.3-6.5 kV module**
 - (Infineon XHP™ standard footprint)
 - Internal design is customized to enable SiC high switching frequency operation with low loop inductance <20 nH
 - **10kV SiC MOSFET XHV-6 Power Module**
 - Up to 240A, half-bridge topology



900-1700 V HT-3000
Series Half-Bridge

900-1700 V HT-4000
Series H-Bridge



3.3-6.5 kV
Half-Bridge



10kV XHV-6
Half-bridge



*Wolfsppeed*TM

*Leading the Pack*TM